

INFLUENCE OF ELECTRON BEAM IRRADIATION ON PHYSICAL PROPERTIES OF MICROWAVE PLASMA SYNTHESIZED GRAPHENE NANOSHEETS

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Abstract

Scanning electron microscopy was used to determine physical properties of microwave plasma synthesized graphene nanosheets such as size and shape under various electron beam parameters (accelerating voltage, electron beam current, working distance). The stability and amount of defects of graphene nanosheets structure was investigated in dependence on these parameters and the results were compared to data obtained by TEM and Dynamic light scattering (DLS). Electron beam irradiation lead to change of nanosheets topography and defect formation was observed as well. The amorphization of the carbon nanostructure led to increase of intensity of D band (1360 cm⁻¹) in Raman spectra. Contrary to electron beam irradiation damage the high temperature annealing, up to 800 °C, in Ar led to no observable changes.

Keywords: Graphene, electron microscopy, irradiation, structure

1. INTRODUCTION

Carbon forms several allotropes with predominantly sp2 bond structure such as fullerenes [1], carbon nanotubes [2] and graphene [3]. These nanostructures can be prepared by wide range of methods including laser and arc discharge evaporation of carbon electrodes in He atmosphere [4] and plasma enhanced chemical vapour deposition using hydrocarbon or alcohol precursors in argon [5-6]. The stability of these structures is highly dependent on the amount of defects and overall sp2/sp3 bond ratio and strongly influences thermal stability and chemical reactivity of the material. Recently, high energy beam irradiation-induced damage to graphene has been investigated experimentally. The effects of plasma treatment, electron beam irradiation and low energy ions were studied in controlled way on graphene sheets to assess the influence of crystal structure and graphene properties with defects. Most studies deal with the low and medium energy electron-beam irradiation in the eV to keV energy regime [7-8]. In this energy regime the interaction regime of electrons and ions is dominated by elastic collisions, and the damage is due to nuclear collisions between impacting charged particles and carbon atoms [9].

Similarly, the choice of electron beam parameters can lead to enhanced contrast, but also damage the observed nanostructures deposited on dielectric substrate. Huang et al. [10] showed that by choosing appropriate acceleration voltage and working distance (WD) can lead to strong enhancement of image contrast and lower the noise level of imaged graphene sheets. This can be used not only to differentiate between substrate and graphene but also make distinction between graphene sheets with different thickness and features such as wrinkles and contaminants. These wrinkles and edges of carbon nanostructures can lead to field emission of electrons [11-12] and influence the quality of obtained image. Further decrease of acceleration voltage using cathode lens in STEM to tens of eVs [13-14] can be used to distinguish freestanding single layer graphene from thicker areas of the sample and topological defects. In this work we study the influence of



electron beam parameters during scanning electron microscopy on contrast between graphene nanosheets and SiO₂ substrate and on their properties.

2. EXPERIMENTAL

The graphene nanosheets were synthesized by ethanol decomposition in microwave plasma torch at atmospheric pressure. The microwave discharge was ignited inside reactor formed by quartz tube (80 mm diameter, 200 mm length) terminated by dural flanges. The discharge electrode was hollow nozzle with central channel used for introduction of working gas - argon (360 - 920 sccm) and subsequent ignition of plasma and secondary channel (annulus with outer radius 8.4 mm and inner radius 7.7 mm) was used for introduction of carrying gas - argon (500 - 1400 sccm) with precursor (ethanol 2-25 sccm) vapours into the plasma environment. Synthesized nanopowder was collected from the reactor wall or on the Si/SiO₂(92 nm) substrates fixed in the holder **Figure 1**. More details about the experimental setup can be found in [15].

The thermal stability study was carried out by samples annealing in quartz glass tube (100 cm long, inner diameter 45 mm) placed in the centre of cylindrical horizontal furnace (40 cm length, hot zone length of 15 cm) terminated with flanges. The temperature inside the furnace was measured by the type S thermocouple and controlled by electronic unit. The gas flow rates were controlled by electronic flow meters and the whole system was evacuated by a turbomolecular pump. The graphene nanosheets powder was put into a quartz boat and placed in the middle of the furnace. The annealing was done in the following sequence. The whole experimental setup was flushed by Ar flow (2.5 lpm) for 5 minutes to avoid the air impurities during the annealing. The sample was heated to its target temperature (350 - 800 °C, 25 °C/minute) under chosen atmosphere Ar (1000 sccm) or air and kept there for 15 minutes. The sample was then rapidly cooled by shifting the oven with regard to sample position by 30 cm and cooled down under Ar flow 1000 sccm to the room temperature.

Raman spectroscopy was carried out using HORIBA LabRAM HR Evolution system with 532 nm laser, using 100x objective and 25 % ND filter in the range from 1000 to 3200 cm⁻¹. Samples were imaged with TESCAN scanning electron microscope (SEM) MIRA3 with Schottky field emission electron gun equipped with secondary electron (SE) and back-scattered electron (BSE) detectors as well as characteristic X-ray detector Oxford Instruments EDX analyzer. Transmission electron microscopy was carried out using JEOL JEM-2100F microscope. Size distribution of prepared graphene nanosheets were determined also by means of dynamic light scattering using colloidal analyser Zetasizer Nano ZS (Malvern Pananalytical Ltd.).

3. RESULTS AND DISCUSSION

3.1. Determination of graphene nanosheets size

Electron microscopy was used as primary technique to determine the size of graphene nanosheets. In general the nanosheet shape was rectangular but their edges are often curled and rolled up which led to their deformation and difficulties in determination of exact size. Therefore, least deformed and clearly visible, not aggregated, nanosheets were selected for image analysis. The size of nanosheets determined from SEM images had length (176 ± 11) nm and width (101 ± 16) nm - see **Figure 2**. This is in agreement with size determined from TEM micrographs **Figure 3** (length (178 ± 16) nm and width (128 ± 6) nm. To compare the obtained value with independent technique, the samples were analyzed by DLS. The obtained distribution of particle sizes can be seen in **Figure 4**. The size distribution function is skewed to the larger values with the average particle size (459 ± 6) nm. The particle size uncertainty refers to three independent measurements of average particle size. This significant shift can be attributed to the formation of dimers or trimers in dispersion and presence of solvation layer around the analysed graphene nanosheets, which overestimates the measured size in DLS measurement in comparison to SEM and TEM.





Figure 1 SEM image of as deposited nanosheets



Figure 2 Determination of nanosheets size by SEM



Figure 3 TEM image of graphene nanosheets



Figure 4 DLS size distribution of graphene nanosheets

3.2. Enhancement of imaging contrast of graphene nanosheets on SiO₂ substrate

To improve imaging and determination of areas of overlapping nanosheets and curled edges we investigated the influence of working parameters on image contrast. In comparison with Huyang, we tried to change the image parameters to obtain the best contrast for graphene nanosheets. The nanosheets are small, hundreds of nm, so we need to get an image with the best resolution. This requirement leads to the choice of higher values of acceleration voltage and short working distance. However, as Huang has shown, it is far preferable to choose a rather long working distance to obtain a high contrast between the substrate (SiO₂) and graphene. Better contrast values (CV), similarly to work of Huang et al. [10] were based on longer working distances. The reason was minimization of the contribution of electrons of type SE3 (originate form backscatter electron colliding with chamber walls and other interior components). Because the escape area of these electron is large (tens to hundreds of nanometers), the resolution increases as the number of these electrons decreases. Contrary to Huang our contrast was negative, we obtained the light graphene on the dark silicon dioxide. The reason could be due to a poorer conductive connection of the individual graphene nanosheets to the substrate, which increased nanosheets charging. In dependence on WD and acceleration voltage we investigated CV between carbon nanosheets and **Figure 5**.





Figure 5 The comparison of the resolution and contrast (CV) for working distance 5 mm (above) and 40 mm (below), acceleration voltage of 20 kV

In this way, we could use enhanced CV to determine boundaries between two overlapping sheets and their edges - **Figure 6**.



Figure 6 Enhanced contract in SEM between two graphene nanosheets and their edges WD 20mm, acceleration voltage 20 kV

3.3. Influence of electron beam irradiation on nanosheet imaging

To investigate the influence of the electron beam on the stability of graphene nanosheets, we applied different electron beam current, acceleration voltage, and different exposure time for nanosheet analysis. The beam



current was varied from 90 pA to 100 pA, acceleration voltage from 5 kV to 30 kV to reach varying dose (energy per area). The acquisition time was 32 s, so the electron beam stays 35 microseconds on one pixel (2.7 x 2.7 nm) and the pixel obtains the dose about 50 pikoJ. The first total dose absorbed by the imaged nanosheet was 8.5 microjoule. The second absorbed dose was 30.7 microjoule **Figure 7**. The highest dose led to amorphization of the structure which was also observed in Raman spectra by increase of D band (1360 cm⁻¹) intensity.

These results are consistent with the work of Teweldebrhan et al. [7] which showed that graphene lattice is strongly influenced by electron beam of energy between 5-20 kV and leads to strong enhancement of D band (1345 cm⁻¹) in Raman spectra and leads to amorphization of carbon material. While this process results in graphene damage it can be used to create various features such as nanopores, slits and gaps in graphene sheets as shown by Fischbein et al. [8].



Figure 7 The same nanosheet a) as deposited b) after 8.5 µJ dose and c) after next 30.7 µJ dose

3.4. Influence of high temperature annealing on nanosheet structure

High temperature annealing in vacuum, Ar and oxygen containing atmosphere was carried out in temperate range of 350 to 800 °C. In the case of vacuum and Ar atmosphere annealing, no significant changes were observed in the structure of the annealed material in whole temperature range as observed by SEM and as shown by Raman spectroscopy analysis. Intensity and ratio of D (1360 cm⁻¹), G (1580 cm⁻¹) and second order 2D (2690 cm⁻¹) bands, I_D/I_G of 0.5 and I_{2D}/I_G ratio of 0.6 remain the same up to 700 °C and I_D/I_G ratio decreased and I_{2D}/I_G ratio increased at 800 °C suggesting removal of defects in the structure. In the case of oxygen containing atmosphere the trend was opposite and above 650 °C the material started to oxidize and was burnt out above 700 °C. The increasing I_D/I_G ratio could be understood in terms of increasing number of defects due to the reaction of carbon atoms with oxygen and further disintegration of graphene nanosheet.

4. CONCLUSIONS

Influence of electron beam parameters in scanning electron microscope on imaging and properties of graphene nanosheets was investigated. The size of nanosheets determined from SEM was slightly smaller than size determined from TEM analysis. This result was partially caused by fuzzy image contrast of SEM especially in case of nanosheets edges. Therefore, we optimized our imaging setting to enhance contrast between substrate and nanosheets. Deformation of nanosheets was investigated in dependence on electron beam irradiation and high temperature annealing. While high temperature annealing in vacuum and argon atmosphere had no observable effect on nanosheets size and structures, as determined by SEM and Raman spectroscopy, the high intensity electron beam irradiation, above a few microjoule per nanosheet, led to modification of graphene edges and change of shape of observed nanostructures.



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